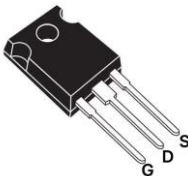


Description
150V N-CHANNEL ENHANCEMENT MODE POWER MOSFET
Features

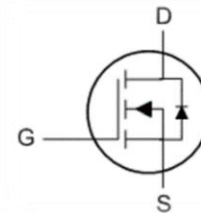
- Device Rating $V_{DS} = 150V$, $I_D = 434A$
- $R_{DS(ON)} = 2.5m\Omega$ (typ.) @ $V_{GS} = 10V$, $I_D = 100A$
- Advanced Split Gate Trench Device Design
- RoHS Compliant & Halogen-Free
- Qualified according to JEDEC for target applications
- 100% Avalanche Test

Application

- Motor Driving
- Battery Management System

Package


TO-247-3L
JFG434N150A


Absolute Maximum Ratings $T_J = 25^\circ C$ unless otherwise specified

Symbol	Parameter	Value	Units	
V_{DS}	Drain-Source Voltage	150	V	
V_{GS}	Gate-Source Voltage	± 20	V	
I_D	Continuous Drain Current, $V_{GS} @ 10V$ ^{note1}	$T_C = 25^\circ C$	434	A
		$T_C = 100^\circ C$	274	A
I_{DM}	Pulsed Drain Current ^{note2}	1272	A	
P_D	Power Dissipation ^{note4}	$T_C = 25^\circ C$	1041	W
	Power Dissipation	$T_A = 25^\circ C$	6.25	W
E_{AS}	Single Pulsed Avalanche Energy ^{note3}	1652	mJ	
T_J, T_{STG}	Operating and Storage Temperature Range	-55 to +150	$^\circ C$	

Thermal characteristics

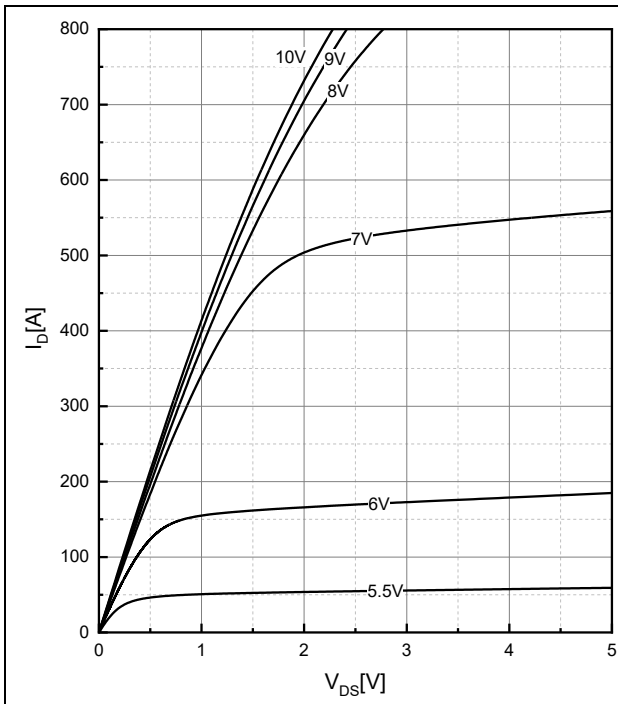
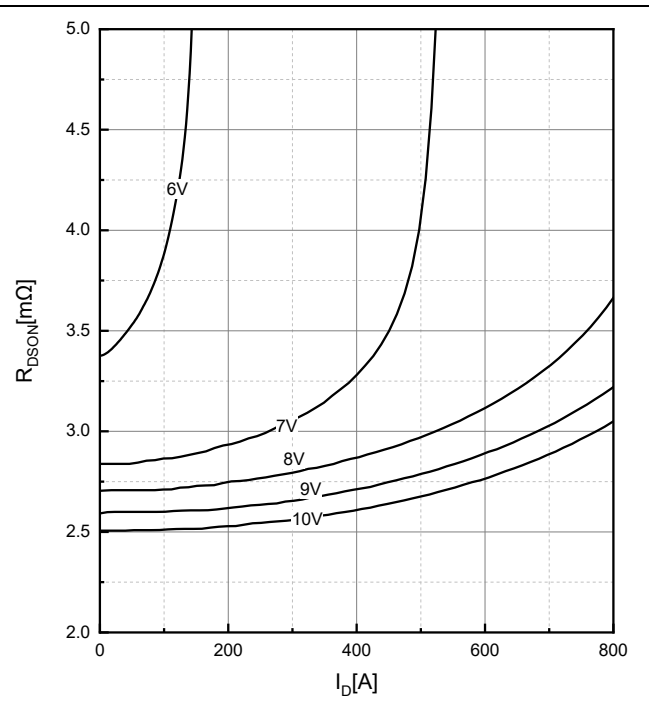
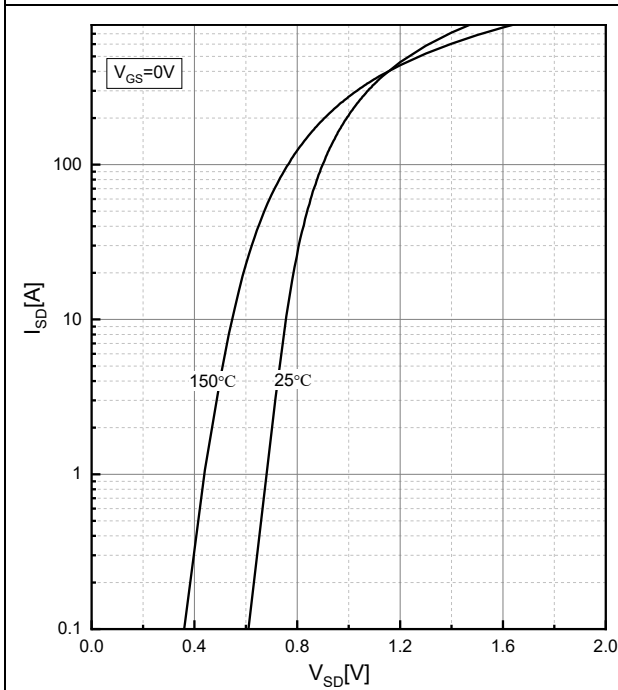
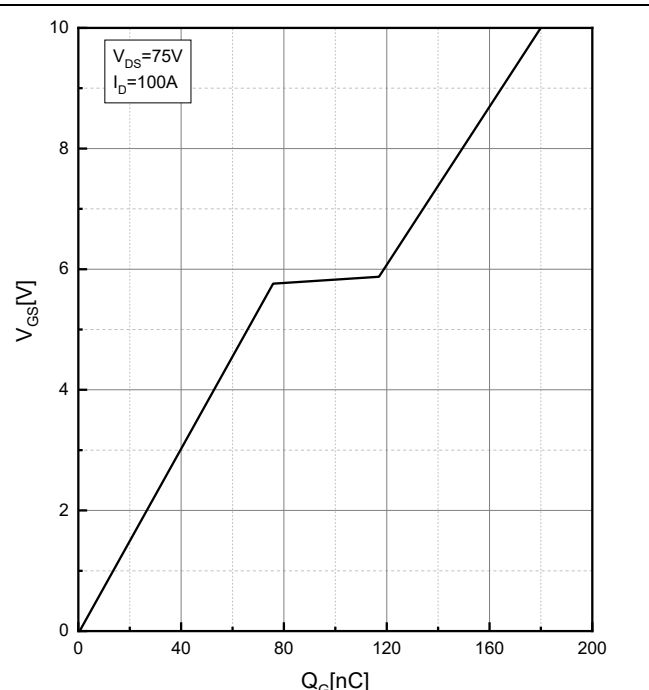
Symbol	Parameter	Min.	Typ.	Max.	Units
$R_{\theta JC}$	Thermal Resistance, Junction to Case	-	0.12	-	$^\circ C/W$
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient ^{note1}	-	-	40	$^\circ C/W$

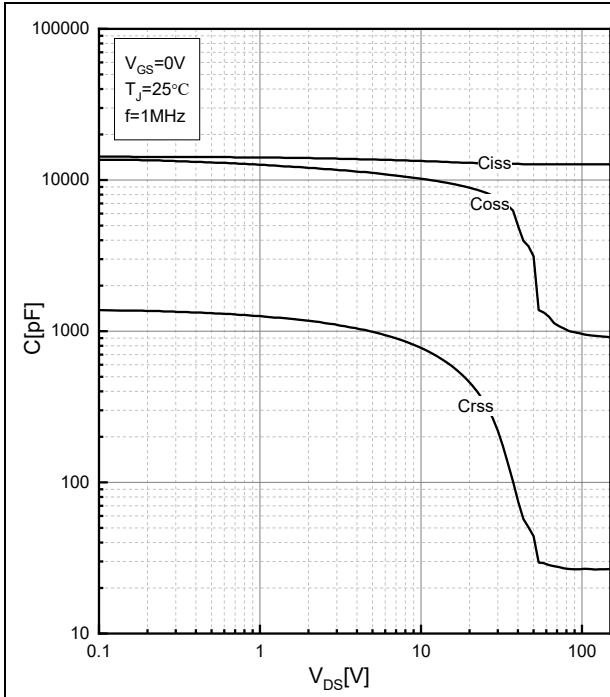
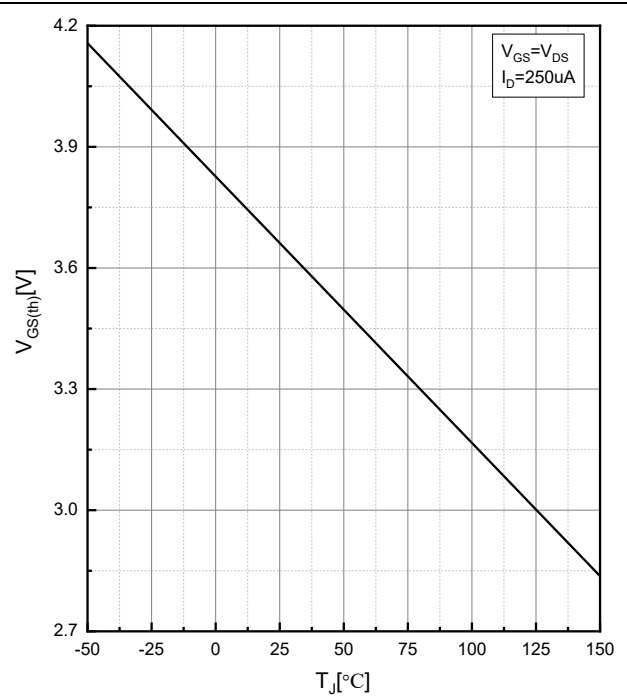
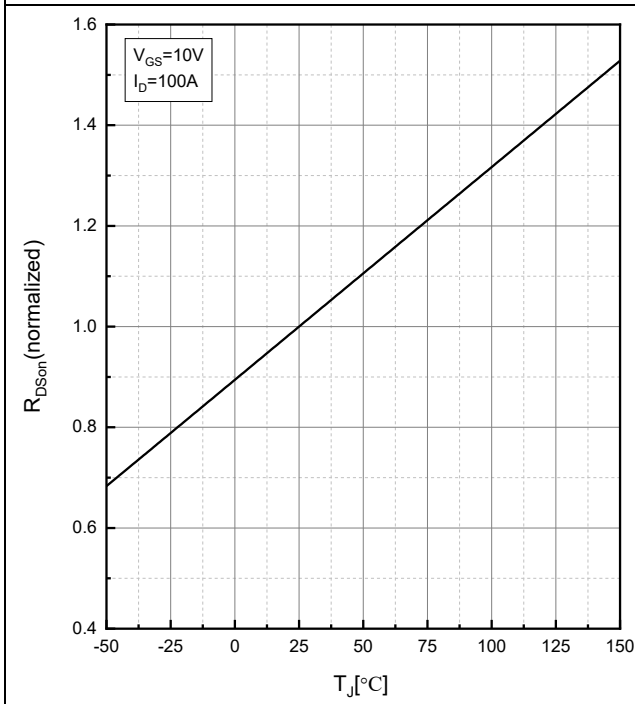
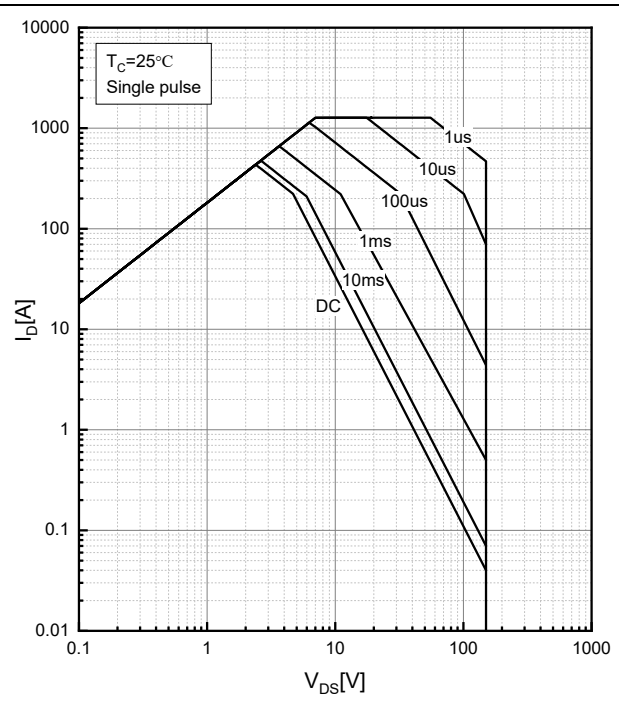
Electrical Characteristics $T_J=25^\circ\text{C}$ unless otherwise specified

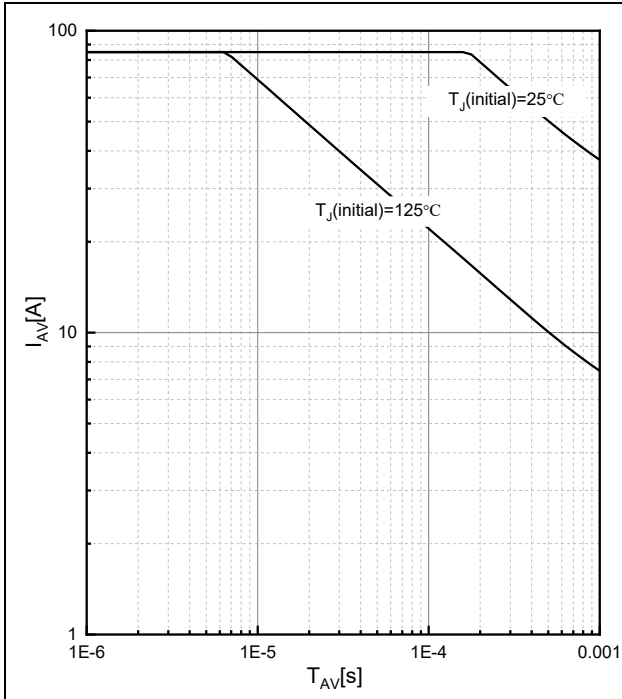
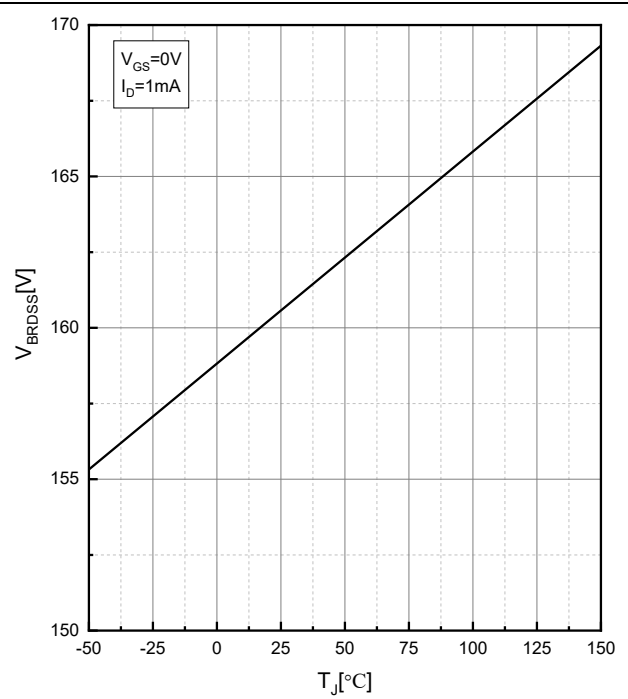
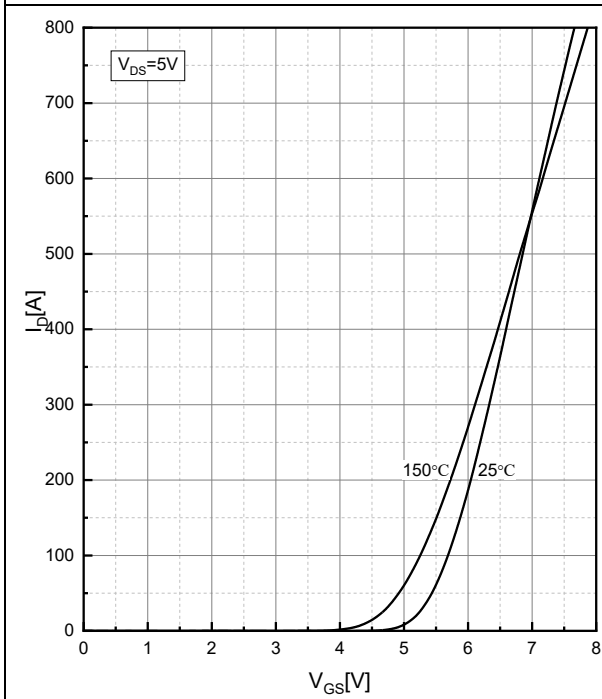
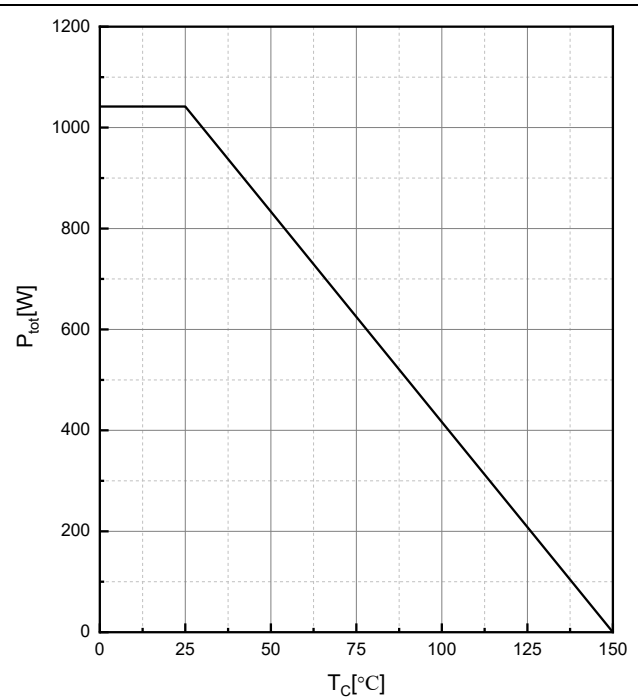
Symbol	Parameter	Test Condition	Min.	Typ.	Max.	Units	
Off Characteristic							
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0V, I_D = 250\mu A$	150	-	-	V	
I_{DSS}	Drain-Source Leakage Current	$V_{DS} = 150V, V_{GS} = 0V, T_J = 25^\circ\text{C}$	-	-	1	μA	
		$V_{DS} = 150V, V_{GS} = 0V, T_J = 125^\circ\text{C}$	-	-	100	μA	
I_{GSS}	Gate-Source Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 20V$	-100	-	100	nA	
On Characteristics							
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250\mu A$	3	-	4.6	V	
$R_{DS(on)}$	Static Drain-Source On-Resistance <small>note2</small>	$V_{GS} = 10V, I_D = 100A$	-	2.5	2.9	m Ω	
g_{FS}	Forward Transconductance	$V_{DS} = 5V, I_D = 100A$	-	241	-	S	
Dynamic Characteristics							
R_g	Gate Resistance	$f = 1\text{MHz}$	-	1.3	-	Ω	
C_{iss}	Input Capacitance	$V_{DS} = 75V, V_{GS} = 0V,$ $f = 1\text{MHz}$	-	13900	-	pF	
C_{oss}	Output Capacitance		-	1180	-	pF	
C_{rSS}	Reverse Transfer Capacitance		-	36	-	pF	
Q_g	Total Gate Charge	$V_{DS} = 75V, I_D = 100A,$ $V_{GS} = 10V$	-	180	-	nC	
Q_{gs}	Gate-Source Charge		-	75	-	nC	
Q_{gd}	Gate-Drain("Miller") Charge		-	41	-	nC	
Switching Characteristics							
$t_{d(on)}$	Turn-On Delay Time	$V_{DD} = 75V, I_D = 100A,$ $R_G = 1\Omega, V_{GS} = 10V$	-	36	-	ns	
t_r	Turn-On Rise Time		-	42	-	ns	
$t_{d(off)}$	Turn-Off Delay Time		-	38	-	ns	
t_f	Turn-Off Fall Time		-	36	-	ns	
Source-Drain Diode Characteristics and Maximum Ratings							
I_S	Maximum Continuous Diode Forward Current <small>note1,5</small>		-	-	434	A	
I_{SM}	Maximum Pulsed Diode Forward Current <small>note2,5</small>		-	-	1272	A	
t_{rr}	Reverse Recovery Time	$T_J = 25^\circ\text{C}, I_S = 100A,$ $V_{GS} = 0V, di/dt = 100A/\mu s$	-	159	-	ns	
Q_{rr}	Reverse Recovery Charge		-	495	-	nC	
V_{SD} <small>note2</small>	Diode Forward Voltage	$I_S = 50A,$ $V_{GS} = 0V$	$T_J = 25^\circ\text{C}$	-	0.85	-	V
			$T_J = 125^\circ\text{C}$	-	0.76	-	V

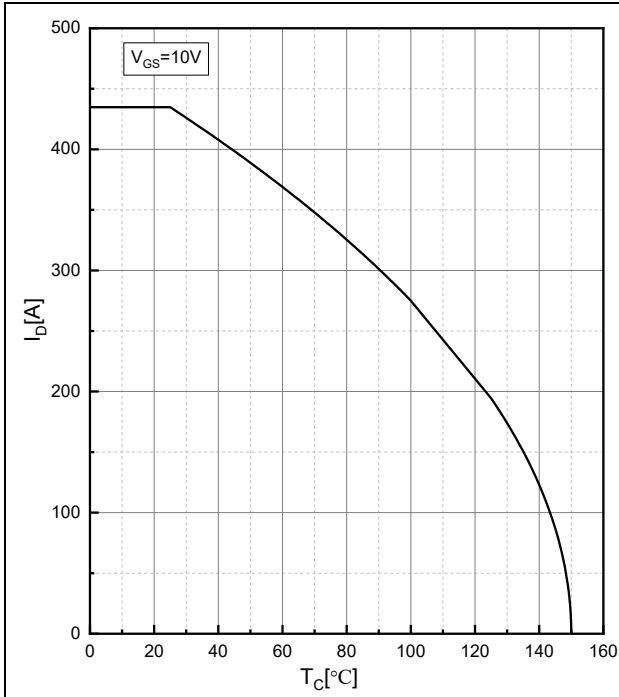
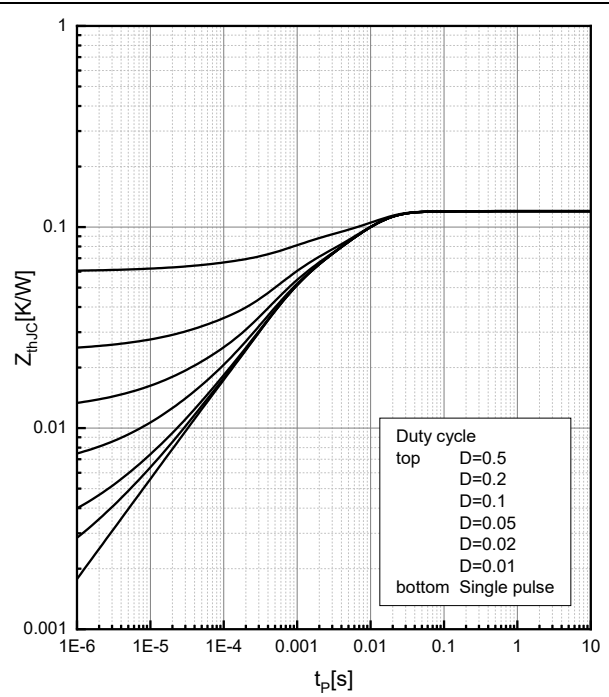
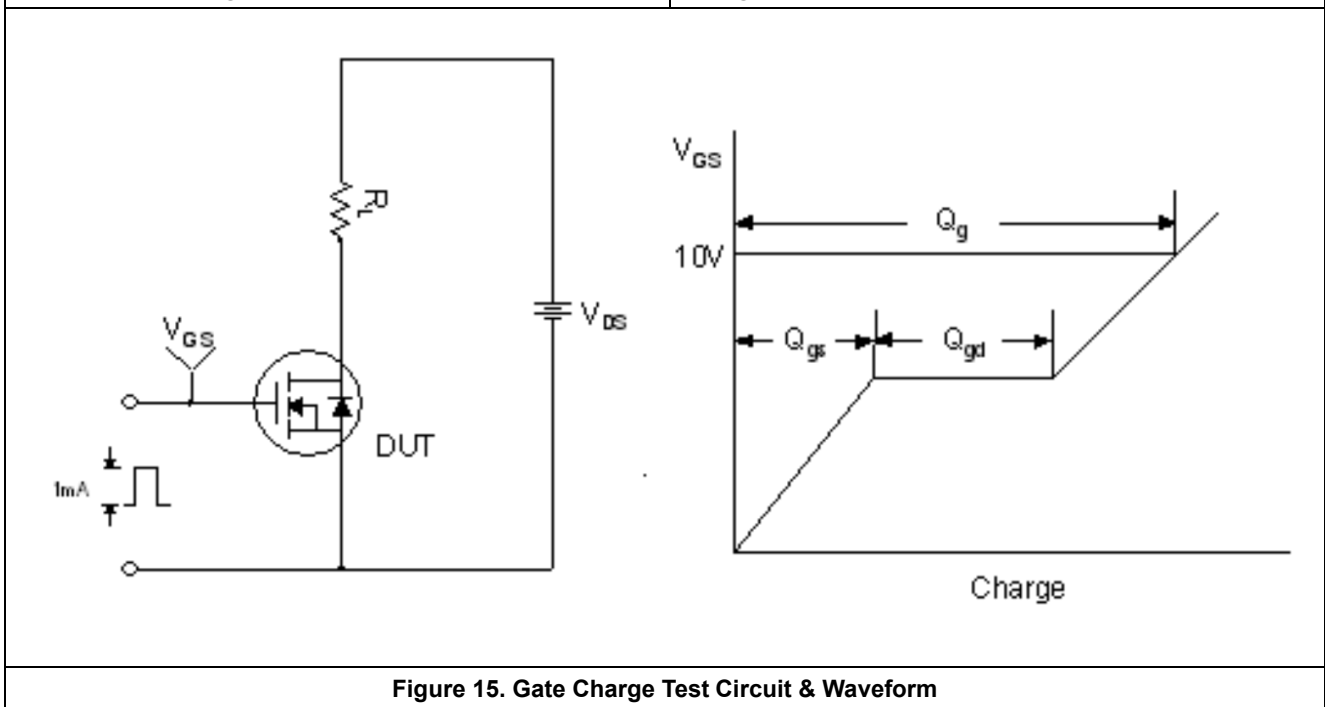
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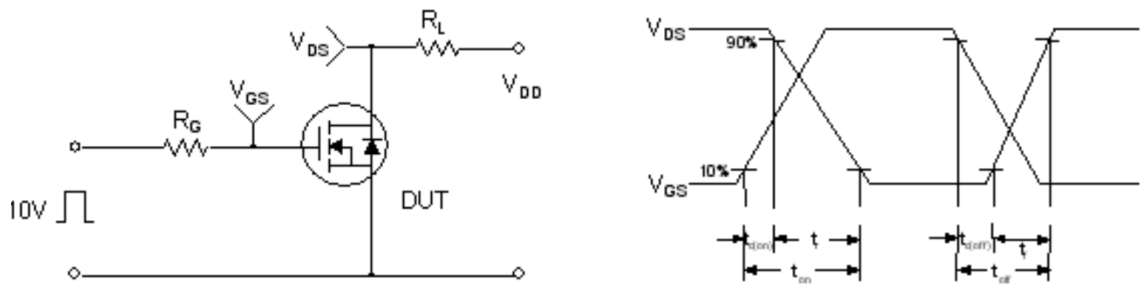
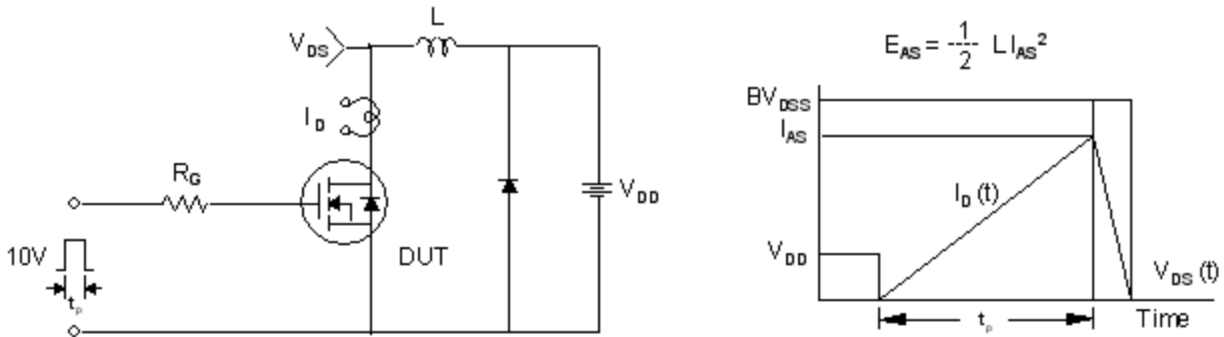
- The data tested by surface mounted on one inch² FR-4 board with 2OZ copper.
- The data tested by pulsed, pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$.
- The EAS data shows Max. rating. The test condition is $L=0.5\text{mH}$, $I_{AS} = 85\text{A}$.
- The power dissipation is limited by 150°C junction temperature.
- The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.

Typical Performance Characteristics

Figure 1. Output Characteristics, $T_J=25^\circ\text{C}$

Figure 2. Drain-source on resistance, $T_J=25^\circ\text{C}$

Figure 3. Forward characteristics of body diode

Figure 4. Gate Charge Characteristics


Figure 5. Capacitance Characteristics

Figure 6. Threshold Voltage Vs. Temperature

Figure 7. Drain-source on-state resistance

Figure 8. Maximum Safe Operating Area


Figure 9. Avalanche characteristics

Figure 10. Drain-source breakdown voltage

Figure 11. Transfer characteristics

Figure 12. Power dissipation


Figure 13. Drain current

Figure 14. Effective Transient Thermal Impedance

Figure 15. Gate Charge Test Circuit & Waveform


Figure 16. Resistive Switching Test Circuit & Waveforms

Figure 17. Unclamped Inductive Switching Test Circuit & Waveforms

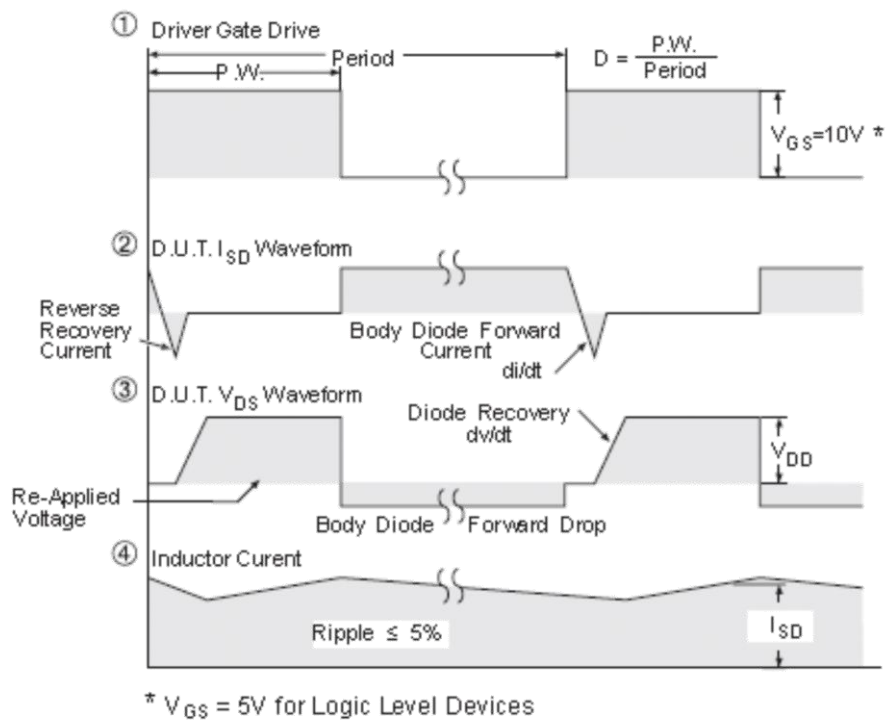
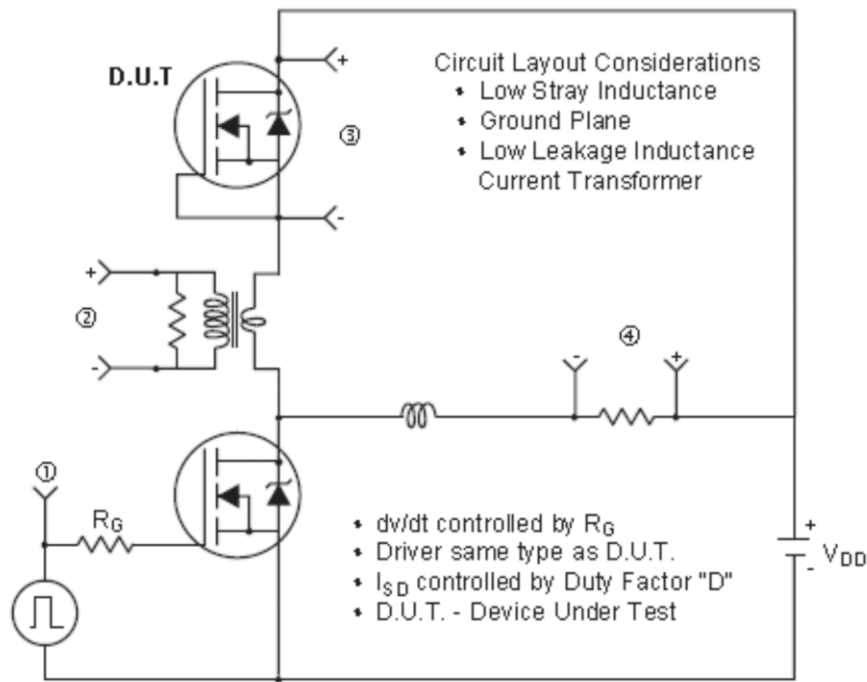


Figure 18. Peak Diode Recovery dv/dt Test Circuit & Waveforms (For N-channel)

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